

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/680,124	LEE, IPSON	
Examiner	Art Unit	
Nhan T. Le	2685	

SEARCHED					
Class	Subclass	Date	Examiner		
485	334 348	वीयिव	Whe		
	550.1				
	557				
235	380				
	439				
	441				
	453				
379	355.01				
	356				
	357.1,2	Ψ			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
DGTA	B text	search		
See M	B text			
		01/12/08	N.Le	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East Search	01/12/08			
Interference Search History printout	01/12/08	W.Le		